

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

APPLICANT: Rück et al.

SERIAL No. Unassigned

EXAMINER: Unassigned

FILED: Herewith

GROUP NO.: Unassigned

TITLE: HIGH ACCURACY WAVEMETER

Attorney Docket No.: US 20-00-3003

Assistant Commissioner For Patents  
Washington, D.C. 20231

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July 20, 2001 (Date of Deposit)

Allison Berkman  
Name

Allison Berkman  
Signature

**PRELIMINARY AMENDMENT**

Dear Sir:

Please amend the application as set forth below.

In The Specification

On page 1, line 4, insert -- 1. Field of the Invention --.

On page 1, line 7, insert -- 2. Discussion of the Background Art --.

In The Abstract

Please amend the abstract as follows:

A wavemeter for determining a wavelength of an incoming optical beam includes a coarse-measuring unit determining in a first wavelength range a first wavelength value as representing the wavelength of the incoming optical beam, and a fine-measuring unit providing a wavelength determination for the incoming optical beam that is ambiguous within the first wavelength range but unambiguous in each of a plurality of unambiguous wavelength ranges, so that a number of different wavelength values correspond to a measuring value as